Application/Control No. Applicant(s)/Patent Under Reexamination 10/075,833 LE NAOUR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Nhan T Le 2685 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,285,863 455/234.1 09-2001 Zhang, Zexiang Α US-6,690,944 02-2004 В Lee et al. 455/522 US-С D US-US-Ε US-F US-G US-US-US-US-Κ

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